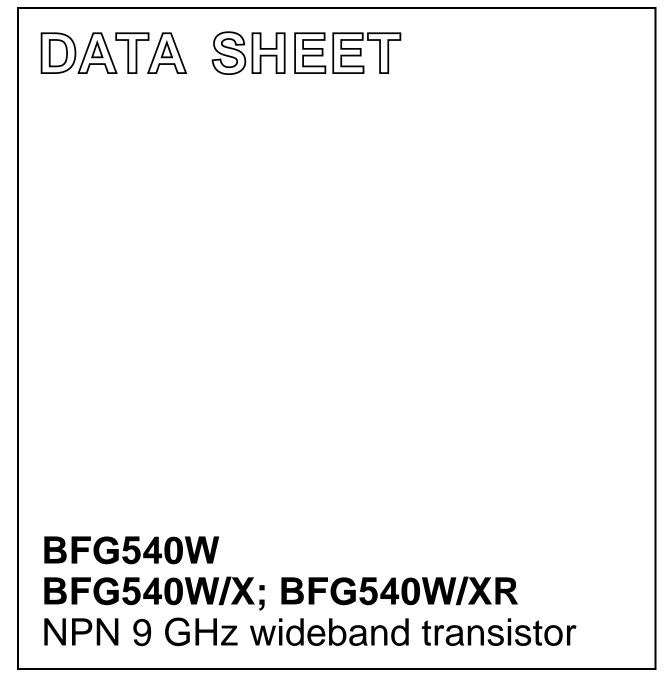
DISCRETE SEMICONDUCTORS



Product specification Supersedes data of 1997 Dec 04 2000 May 23



FEATURES

- · High power gain
- Low noise figure
- · High transition frequency · Gold metallization ensures
- excellent reliability.

APPLICATIONS

RF front end wideband applications in the GHz range, such as analog and digital cellular telephones, cordless telephones (CT2, CT3, PCN, DECT, etc.), radar detectors, pagers, satellite television tuners (SATV), MATV/CATV amplifiers and repeater amplifiers in fibre-optic systems.

DESCRIPTION

NPN silicon planar epitaxial transistors in 4-pin dual-emitter SOT343N and SOT343R plastic packages.

MARKING

PINNING

PIN

1

2

3

4

1

2

3

4

1 2

3

4

BFG540W (see Fig.1)

collector

base

emitter

emitter

emitter

emitter

collector

emitter

emitter

base

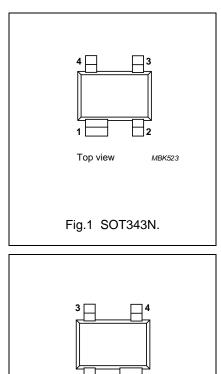
BFG540W/XR (see Fig.2)

base

BFG540W/X (see Fig.1) collector

TYPE NUMBER	CODE
BFG540W	N9
BFG540W/X	N7
BFG540W/XR	N8

DESCRIPTION



Top view

Fig.2 SOT343R.

MSB842

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{CBO}	collector-base voltage	open emitter	_	-	20	V
V _{CES}	collector-emitter voltage	$R_{BE} = 0$	_	-	15	V
Ic	collector current (DC)		-	-	120	mA
P _{tot}	total power dissipation	$T_s \le 85 \ ^{\circ}C$	-	-	500	mW
h _{FE}	DC current gain	I _C = 40 mA; V _{CE} = 8 V	100	120	250	
C _{re}	feedback capacitance	I _C = 0; V _{CB} = 8 V; f = 1 MHz	-	0.5	-	pF
f _T	transition frequency	I_{C} = 40 mA; V_{CE} = 8 V; f = 1 GHz; T_{amb} = 25 °C	-	9	-	GHz
G _{UM}	maximum unilateral	I_{C} = 40 mA; V_{CE} = 8 V; f = 900 MHz; T_{amb} = 25 °C	-	16	-	dB
	power gain	I_{C} = 40 mA; V_{CE} = 8 V; f = 2 GHz; T_{amb} = 25 °C		10	_	dB
s ₂₁ ²	insertion power gain	I_{C} = 40 mA; V_{CE} = 8 V; f = 900 MHz; T_{amb} = 25 °C	14	15	-	dB
F	noise figure	$\Gamma_{s} = \Gamma_{opt}$; I _C = 10 mA; V _{CE} = 8 V; f = 2 GHz	-	2.1	-	dB

BFG540W BFG540W/X; BFG540W/XR

BFG540W/X; BFG540W/XR

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{CBO}	collector-base voltage	open emitter	-	20	V
V _{CES}	collector-emitter voltage	R _{BE} = 0	-	15	V
V _{EBO}	emitter-base voltage	open collector	-	2.5	V
I _C	collector current (DC)		-	120	mA
P _{tot}	total power dissipation	$T_s \le 85 \ ^\circ C$; see Fig.3; note 1	-	500	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-	175	°C

Note

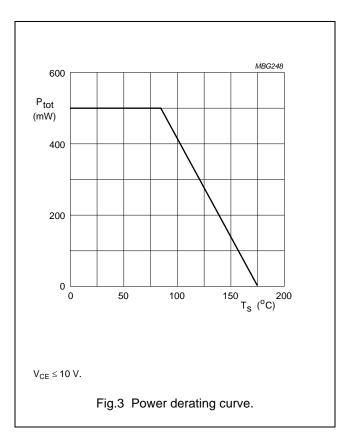
1. T_s is the temperature at the soldering point of the collector pin.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-s}	thermal resistance from junction to soldering point	$T_s \le 85 \ ^\circ C$; note 1	180	K/W

Note

1. $\ensuremath{ T_s}$ is the temperature at the soldering point of the collector pin.



BFG540W/ BFG540W/X; BFG540W/XR

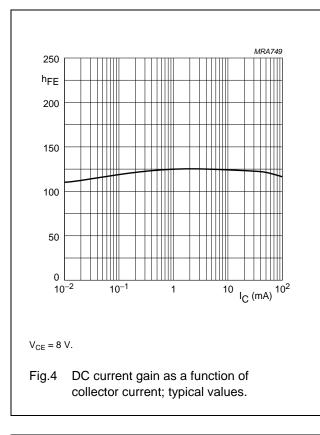
CHARACTERISTICS

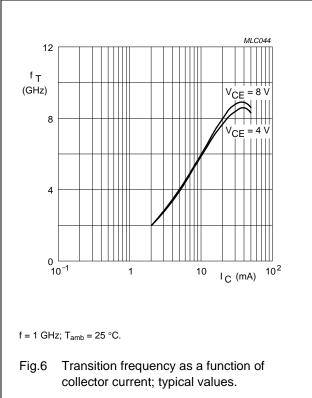
T_j = 25 °C unless otherwise specified.

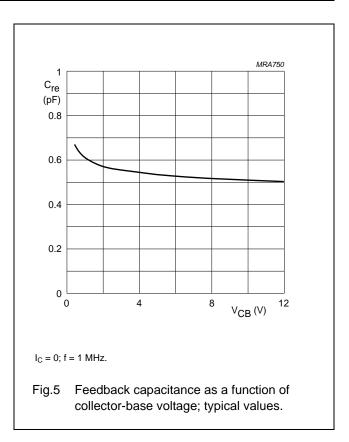
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{(BR)CBO}	collector-base breakdown voltage	open emitter; $I_C = 10 \ \mu A$; $I_E = 0$	20	-	-	V
V _{(BR)CES}	collector-emitter breakdown voltage	R _{BE} = 0; I _C = 40 μA	15	-	-	V
V _{(BR)EBO}	emitter-base breakdown voltage	open collector; $I_E = 100 \ \mu\text{A}$; $I_C = 0$	2.5	-	-	V
I _{CBO}	collector cut-off current	open emitter; $V_{CB} = 8 V$; $I_E = 0$	-	-	50	nA
h _{FE}	DC current gain	I _C = 40 mA; V _{CE} = 8 V	100	120	250	
f _T	transition frequency	$I_C = 40 \text{ mA}; V_{CE} = 8 \text{ V}; f = 1 \text{ GHz};$ $T_{amb} = 25 \text{ °C}$	-	9	-	GHz
C _c	collector capacitance	I _E = i _e = 0; V _{CB} = 8 V; f = 1 MHz	_	0.9	-	pF
Ce	emitter capacitance	$I_{C} = i_{c} = 0; V_{EB} = 0.5 V; f = 1 MHz$	_	2	-	pF
C _{re}	feedback capacitance	I _C = 0; V _{CB} = 8 V; f = 1 MHz	_	0.5	-	pF
G _{UM}	maximum unilateral power gain; note 1	I _C = 40 mA; V _{CE} = 8 V; f = 900 MHz; T _{amb} = 25 °C	-	16	_	dB
		$I_C = 40 \text{ mA}; V_{CE} = 8 \text{ V}; \text{ f} = 2 \text{ GHz};$ $T_{amb} = 25 ^{\circ}\text{C}$	-	10	-	dB
s ₂₁ ²	insertion power gain	$I_{C} = 40 \text{ mA}; V_{CE} = 8 \text{ V}; f = 900 \text{ MHz};$ $T_{amb} = 25 \text{ °C}$	14	15	-	dB
F	noise figure	$\Gamma_s = \Gamma_{opt}$; I _C = 10 mA; V _{CE} = 8 V; f = 900 MHz	-	1.3	1.8	dB
		$\Gamma_{s} = \Gamma_{opt}$; I _C = 40 mA; V _{CE} = 8 V; f = 900 MHz	-	1.9	2.4	dB
		$\Gamma_s = \Gamma_{opt}$; I _C = 10 mA; V _{CE} = 8 V; f = 2 GHz	-	2.1	-	dB
P _{L1}	output power at 1 dB gain compression	I_{C} = 40 mA; V _{CE} = 8 V; f = 900 MHz; R _L = 50 Ω; T _{amb} = 25 °C	_	21	_	dBm
ITO	third order intercept point	note 2	-	34	-	dBm
Vo	output voltage	note 3	-	500	-	mV
d ₂	second order intermodulation distortion	note 4	-	-50	-	dB

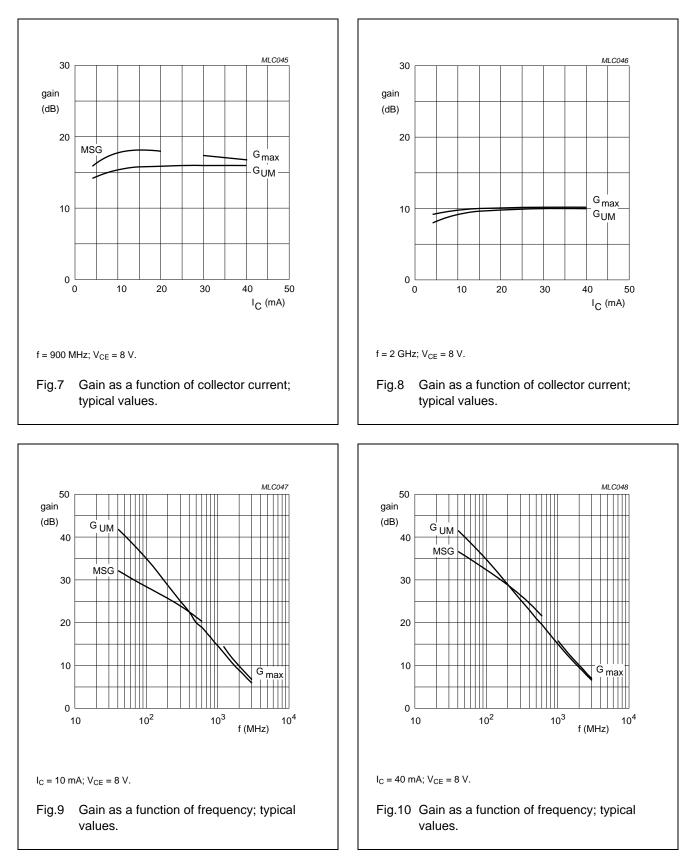
Notes

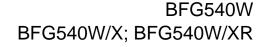
- 1. G_{UM} is the maximum unilateral power gain, assuming s_{12} is zero. $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1-|s_{11}|^2)(1-|s_{22}|^2)} dB$.
- 2. $I_C = 40 \text{ mA}$; $V_{CE} = 8 \text{ V}$; $R_L = 50 \Omega$; $T_{amb} = 25 \text{ °C}$; a) $f_p = 900 \text{ MHz}$; $f_q = 902 \text{ MHz}$; measured at $f_{(2p-q)} = 898 \text{ MHz}$ and $f_{(2q-p)} = 904 \text{ MHz}$.
- 3. $d_{im} = -60 \text{ dB} \text{ (DIN45004B)}; V_p = V_o; V_q = V_o 6 \text{ dB}; V_r = V_o 6 \text{ dB}; R_L = 75 \Omega; V_{CE} = 8 \text{ V}; I_C = 40 \text{ mA};$
 - a) $f_p = 795.25$ MHz; $f_q = 803.25$ MHz; $f_r = 805.25$ MHz; measured at $f_{(p + q r)} = 793.25$ MHz.
- 4. I_C = 40 mA; V_{CE} = 8 V; V_o = 275 mV; R_L = 75 $\Omega;$ T_amb = 25 °C;
 - a) $f_p = 250$ MHz; $f_q = 560$ MHz; measured at $f_{(p+q)} = 810$ MHz.











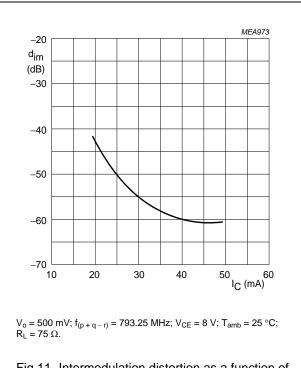
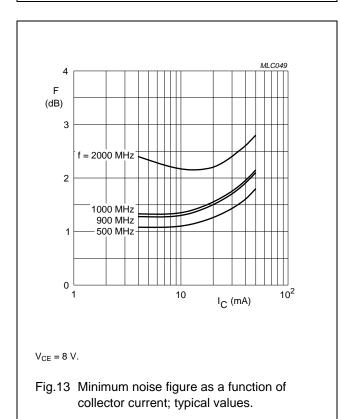


Fig.11 Intermodulation distortion as a function of collector current; typical values.



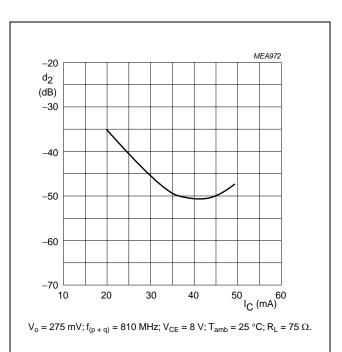
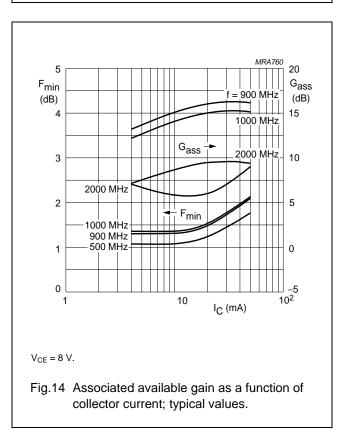
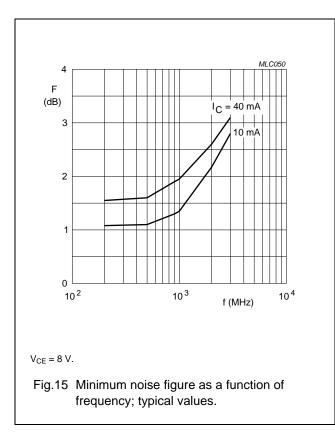
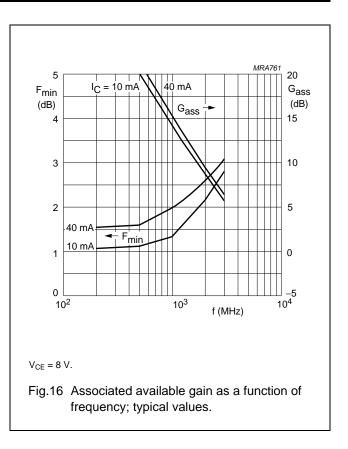
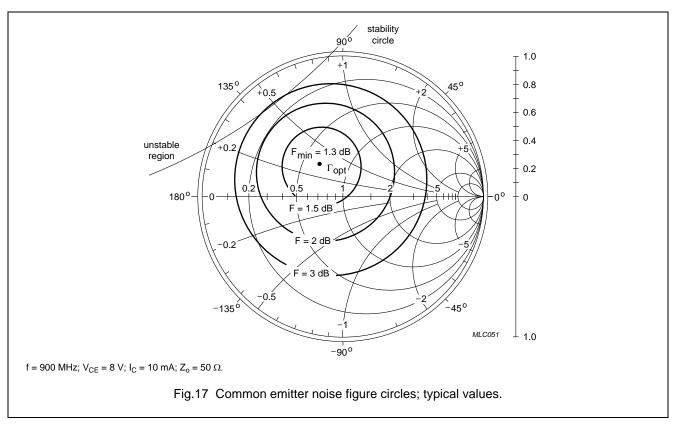


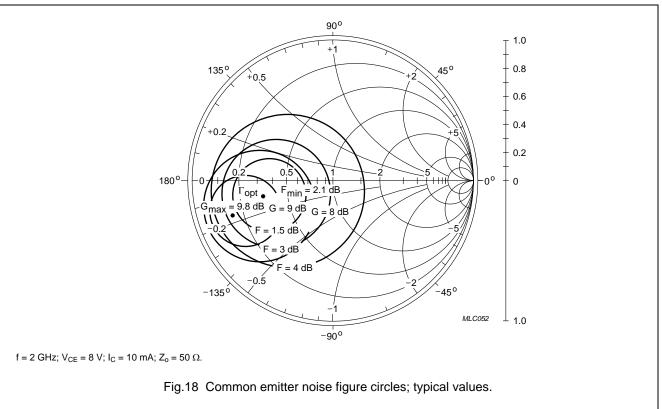
Fig.12 Second order intermodulation distortion as a function of collector current; typical values.

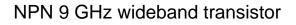




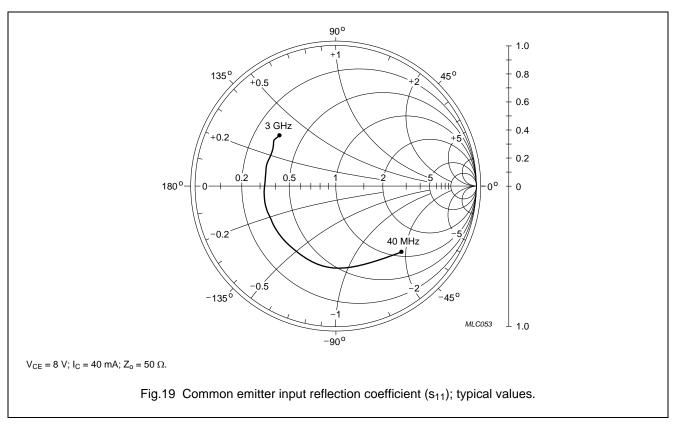


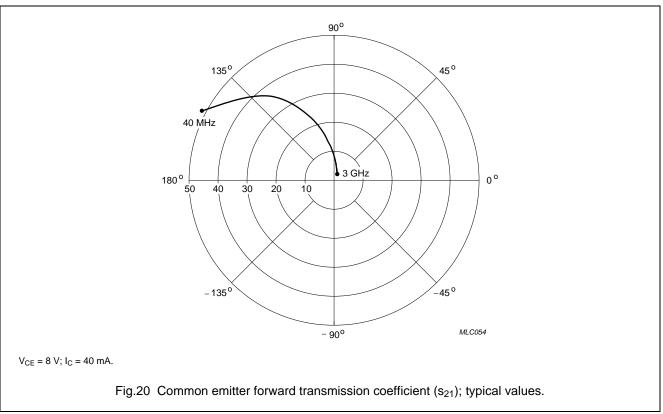


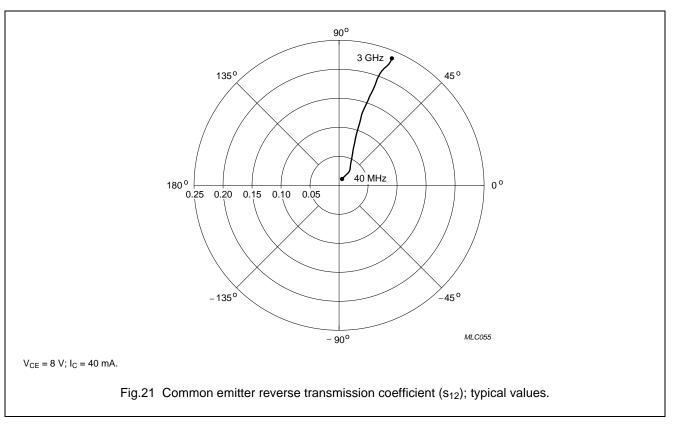


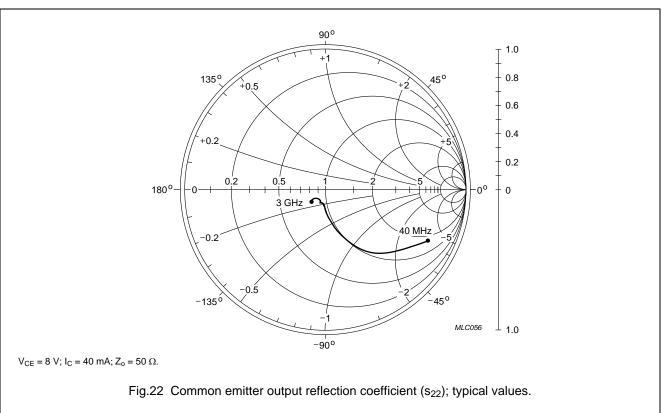


BFG540W BFG540W/X; BFG540W/XR









BFG540W

NPN 9 GHz wideband transistor

SPICE parameters for the BFG540W crystal

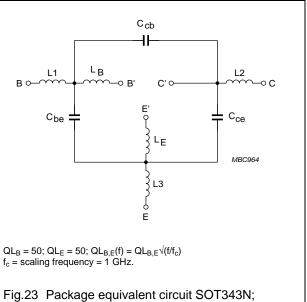
SEQUENCE No.	PARAMETER	VALUE	UNIT
1	IS	1.045	fA
2	BF	184.3	-
3	NF	0.981	-
4	VAF	41.69	V
5	IKF	10.00	А
6	ISE	232.4	fA
7	NE	2.028	-
8	BR	43.99	-
9	NR	0.992	-
10	VAR	2.097	V
11	IKR	166.2	mA
12	ISC	129.8	aA
13	NC	1.064	_
14	RB	5.000	Ω
15	IRB	1.000	μΑ
16	RBM	5.000	Ω
17	RE	353.5	mΩ
18	RC	1.340	Ω
19 ⁽¹⁾	XTB	0.000	-
20 (1)	EG	1.110	eV
21 ⁽¹⁾	XTI	3.000	_
22	CJE	1.978	pF
23	VJE	600.0	mV
24	MJE	0.332	_
25	TF	7.457	ps
26	XTF	11.40	_
27	VTF	3.158	V
28	ITF	156.9	mA
29	PTF	0.000	deg
30	CJC	793.7	fF
31	VJC	185.5	mV
32	MJC	0.084	_
33	XCJC	0.150	_
34	TR	1.598	ns
35 ⁽¹⁾	CJS	0.000	F

VALUE UNIT **SEQUENCE No.** PARAMETER 36 (1) VJS 750.0 mV 37 (1) MJS 0.000 _ 38 FC 0.814 _

BFG540W/X; BFG540W/XR

Note

1. These parameters have not been extracted, the default values are shown.



SOT343R.

List of components (see Fig.23).

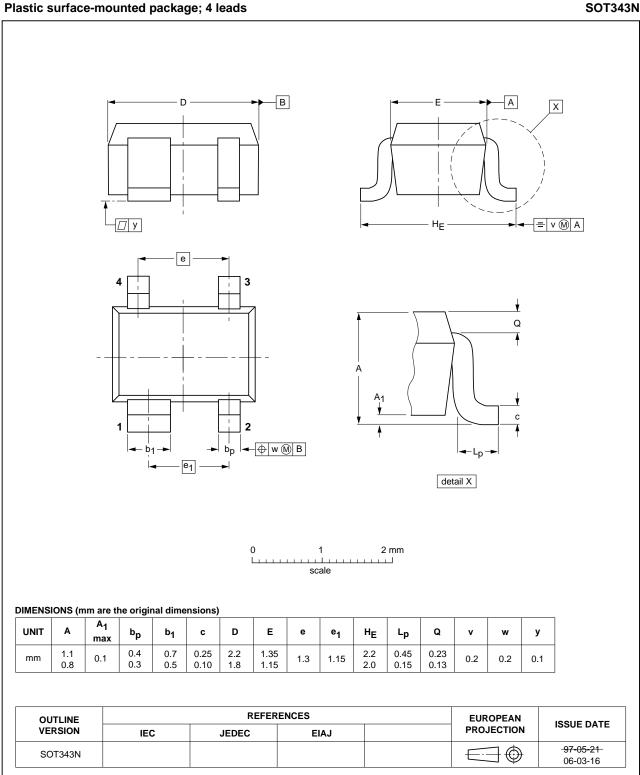
DESIGNATION	VALUE	UNIT
C _{be}	70	fF
C _{cb}	50	fF
C _{ce}	115	fF
L1	0.34	nH
L2	0.10	nH
L3	0.25	nH
L _B	0.40	nH
LE	0.40	nH

BFG540W

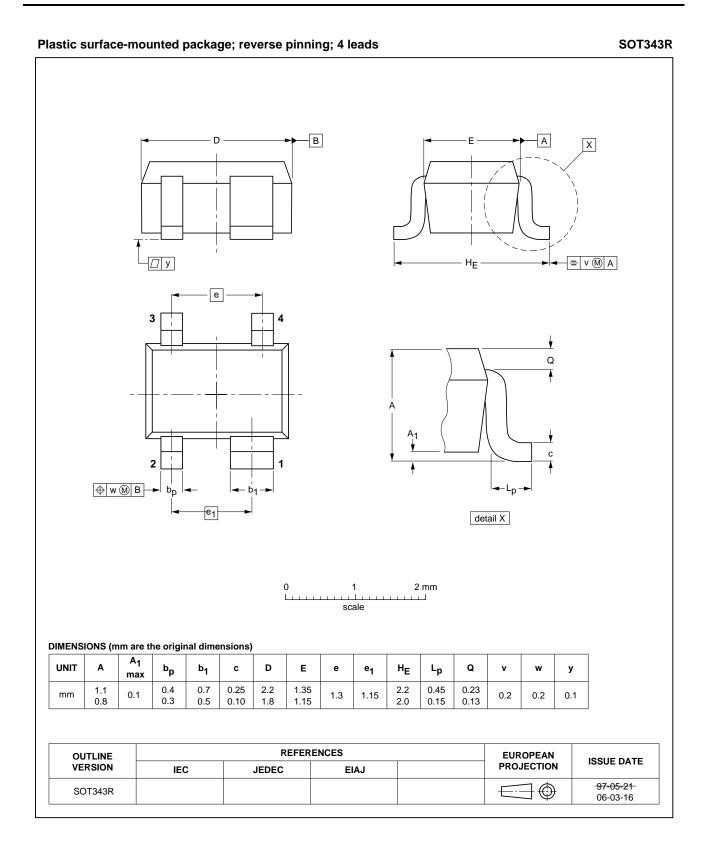
BFG540W/X; BFG540W/XR

NPN 9 GHz wideband transistor

PACKAGE OUTLINES



SOT343N



BFG540W/X; BFG540W/XR

DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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BFG540W/X; BFG540W/XR

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Contact information

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